


<b>Search Notes</b>  	<b>Application/Control No.</b>  10577014	<b>Applicant(s)/Patent Under Reexamination</b>  SANO, HISASHI
	<b>Examiner</b>  RANDOLPH CHU	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	293, 295, 287	6/17/2009	ric
345	619-689	6/17/2009	ric
348	580	6/17/2009	ric
708	442	6/17/2009	ric

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	6/24/2009	ric
Inventor Name Search	6/17/2009	ric
NPL, Internet	6/17/2009	ric
Updated EAST Search	12/9/2009	ric
Updated EAST Search	3/16/2010	ric
Updated EAST Search	11/26/2010	ric
Updated EAST Search	5/4/2011	ric

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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